

Description

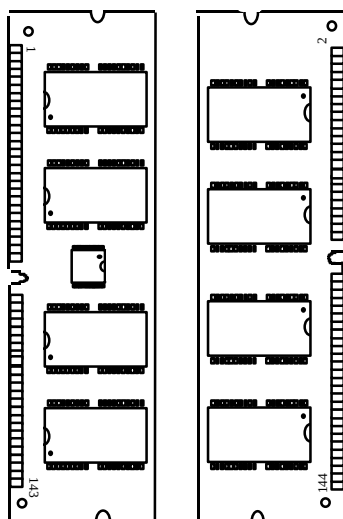
The GMM26417227ANTG is a 16M x 64 bits Synchronous Dynamic RAM SO-DIMM which is assembled 8 pieces of 8M x 16bits Synchronous DRAMs in 54 pin TSOP II package and one 2048 bit EEPROM in 8 pin TSSOP package mounted on a 144 pin printed circuit board with decoupling capacitors. The GMM26417227ANTG is optimized for application to the systems which are required high density and large capacity such as main memory of the computers and an image memory systems, and to the others which are requested compact size.

The GMM26417227ANTG provides common data inputs and outputs.

Features

- * PC100/PC66 Compatible
 - 8(125MHz)
 - 7K(PC100,2-2-2)/-7J(PC100,3-2-2)/-10K(PC66)
- * 3.3V +/- 0.3V Power supply
- * Maximum Clock frequency
 - 100 / 125 MHz
- * LVTTTL Interface
- * Burst read/write operation and burst read/single write operation capability
- * Programmable burst length ;
 - 1, 2, 4, 8, Full page
- * Programmable burst sequence
 - Sequential / Interleave
- * Full Page burst length capability
 - Sequential burst
 - Burst stop capability
- * Programmable CAS Latency ; 2, 3
- * CKE power down mode
- * Input / Output data masking
- * 4096 Refresh Cycles / 64ms
- * Auto refresh / Self refresh Capability
- * Serial Presence Detect with EEPROM

GMM26417227ANTG (Both Side)



Pin Name

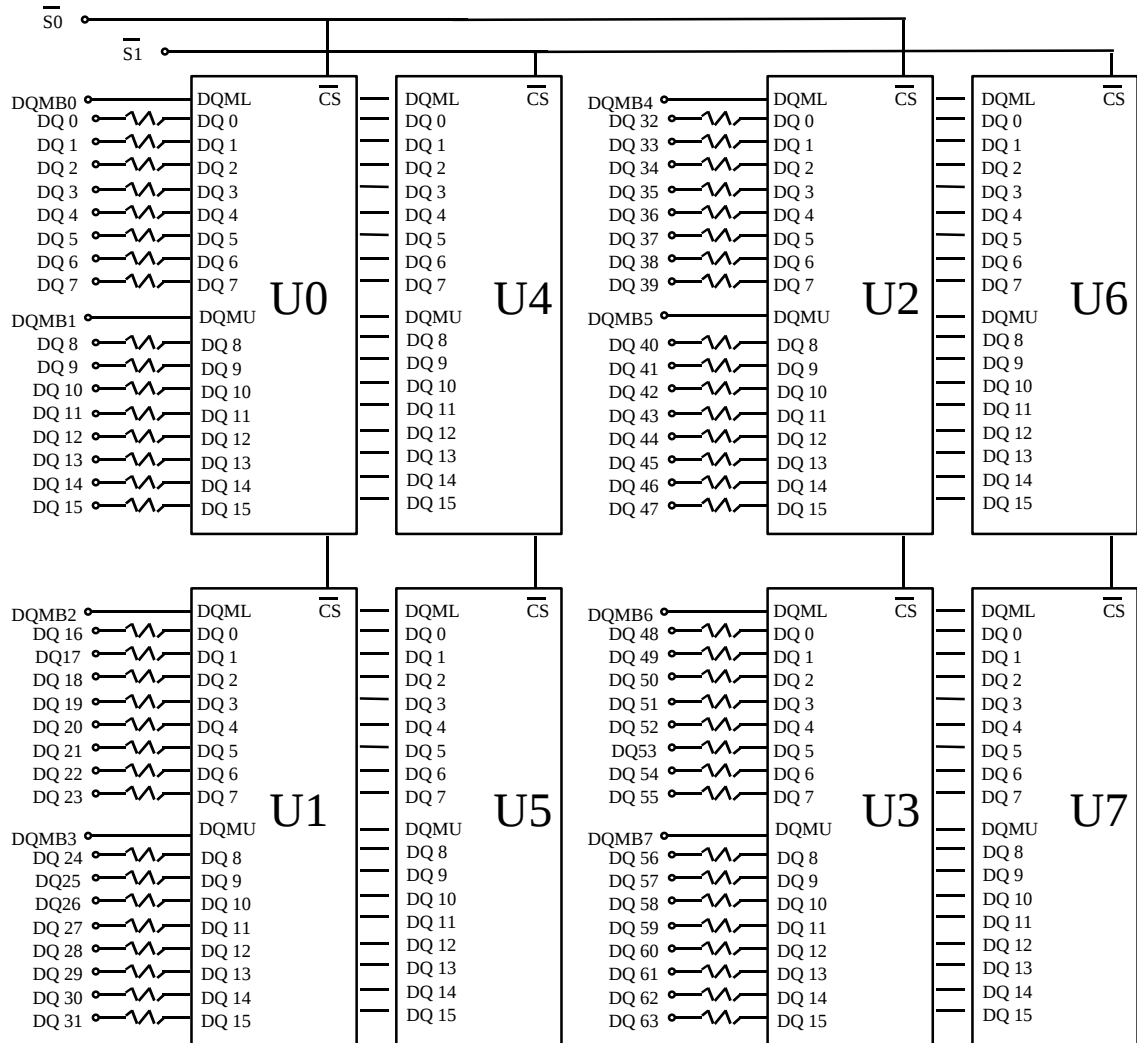
CK0,1	Clock inputs
CKE0,1	Clock Enable
S0,S1	Chip Select
RAS	Row Address Strobe
CAS	Column Address Strobe
WE	Write Enable
A0~A11	Address input
BA0,1	Bank Address input
DQ0~63	Data input / output
DQMB0~7	Data input / output Mask
VCC	Power for internal circuit
VSS	Ground for internal circuit
NC	No Connect
VREF	Power Supply for Reference
SDA	Serial Data input / output
SCL	Serial Clock
DU	Don't Use

Pin Configuration

Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol	Pin	Symbol
1	V _{SS}	25	DQMB1	49	DQ13	73	NU	97	DQ22	121	DQ24
2	V _{SS}	26	DQMB5	50	DQ45	74	CK1	98	DQ54	122	DQ56
3	DQ0	27	V _{CC}	51	DQ14	75	V _{SS}	99	DQ23	123	DQ25
4	DQ32	28	V _{CC}	52	DQ46	76	V _{SS}	100	DQ55	124	DQ57
5	DQ1	29	A0	53	DQ15	77	NC	101	V _{CC}	125	DQ26
6	DQ33	30	A3	54	DQ47	78	NC	102	V _{CC}	126	DQ58
7	DQ2	31	A1	55	V _{SS}	79	NC	103	A6	127	DQ27
8	DQ34	32	A4	56	V _{SS}	80	NC	104	A7	128	DQ59
9	DQ3	33	A2	57	NC	81	V _{CC}	105	A8	129	V _{CC}
10	DQ35	34	A5	58	NC	82	V _{CC}	106	BA0	130	V _{CC}
11	V _{DD}	35	V _{SS}	59	NC	83	DQ16	107	V _{SS}	131	DQ28
12	V _{DD}	36	V _{SS}	60	NC	84	DQ48	108	V _{SS}	132	DQ60
13	DQ4	37	DQ8	61	CK0	85	DQ17	109	A9	133	DQ29
14	DQ36	38	DQ40	62	CKE0	86	DQ49	110	BA1	134	DQ61
15	DQ5	39	DQ9	63	V _{CC}	87	DQ18	111	A10/AP	135	DQ30
16	DQ37	40	DQ41	64	V _{CC}	88	DQ50	112	A11	136	DQ62
17	DQ6	41	DQ10	65	$\overline{\text{RAS}}$	89	DQ19	113	V _{CC}	137	DQ31
18	DQ38	42	DQ42	66	$\overline{\text{CAS}}$	90	DQ51	114	V _{CC}	138	DQ63
19	DQ7	43	DQ11	67	$\overline{\text{WE}}$	91	V _{SS}	115	DQMB2	139	V _{SS}
20	DQ39	44	DQ43	68	CKE1	92	V _{SS}	116	DQMB6	140	V _{SS}
21	V _{SS}	45	V _{CC}	69	$\overline{\text{S0}}$	93	DQ20	117	DQMB3	141	SDA
22	V _{SS}	46	V _{CC}	70	A12*	94	DQ52	118	DQMB7	142	SCL
23	DQMB0	47	DQ12	71	$\overline{\text{S1}}$	95	DQ21	119	V _{SS}	143	V _{CC}
24	DQMB4	48	DQ44	72	A13*	96	DQ53	120	V _{SS}	144	V _{CC}

* These pins are not used in this module

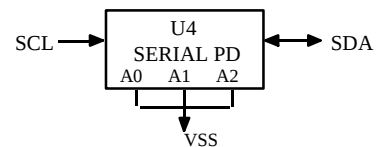
Block Diagram



A0 ~ A11, BA0,1 → U0 - U7
 RAS → U0 - U7
 CAS → U0 - U7
 WE → U0 - U7
 CK0 → U0 - U3
 CK1 → U4 - U7

CK0 → 4 SDRAMS
 CK1 → 4 SDRAMS

Vcc → U0 ~ U7
 Vss → U0 ~ U7
 Capacitor
 two 0.33uF and one 0.1uF per SDRAM



Pin Description

Pin Name	DESCRIPTION
CK0,1 (input pins)	CK is the master clock input to this pin. The other input signals are referred at CK rising edge.
CKE0,1 (input pins)	This pin determines whether or not the next CK is valid. If CKE is High, the next CK rising edge is valid. If CKE is Low, the next CK rising edge is invalid. This pin is used for power-down and clock suspend modes.
$\overline{S}0,1$ (input pins)	When $\overline{S}$ is Low, the command input cycle becomes valid. When $\overline{S}$ is high, all inputs are ignored. However, internal operations (bank active, burst operations, etc.) are held.
$\overline{RAS}$, $\overline{CAS}$ and $\overline{WE}$ (input pins)	Although these pin names are the same as those of conventional DRAMs, they function in a different way. These pins define operation commands (read, write, etc.) depending on the combination of their voltage levels. For details, refer to the command operation section.
A0 ~ A11 (input pins)	Row address (AX0 to AX11) is determined by A0 to A11 level at the bank active command cycle CK rising edge. Column address is determined by A0 to A8 level at the read or write command cycle CK rising edge. And this column address becomes burst access start address. A10 defines the precharge mode. When A10 = High at the precharge command cycle, both banks are precharged. But when A10 = Low at the precharge command cycle, only the bank that is selected by BA0 is precharged.
BA0,1 (input pin)	BA0,1 are bank select signal. If BA0 is Low and BA1 is High, bank 0 is selected. If BA0 is High and BA1 is Low, bank 1 is selected. If BA0 is Low and BA1 is High, bank 2 is selected. If BA0 is High and BA1 is High, bank 3 is selected.
DQ0 ~ DQ63 (I/O pins)	Data is input and output from these pins. These pins are the same as those of a conventional DRAMs.
DQMB0 ~ DQMB7 (input pins)	DQMB controls input/output buffers. Read operation: If DQMB is High, The output buffer becomes High-Z. If the DQMB is Low, the output buffer becomes Low-Z. Write operation: If DQMB is High, the previous data is held (the new data is not written). If DQMB is Low, the data is written.
V _{CC} (power supply pins)	3.3 V is applied. (V _{CC} is for the internal circuit)
V _{SS} (power supply pins)	Ground is connected. (V _{SS} is for the internal circuit)
NC	No Connection pins.

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit	Note
Voltage on any pin relative to V _{SS}	V _T	-0.5 to V _{CC} +0.5 (≤4.6 (max))	V	1
Supply voltage relative to V _{SS}	V _{CC}	-0.5 to +4.6	V	1
Short circuit output current	I _{OUT}	50	mA	
Power dissipation	P _T	1.0	W	
Operating temperature	T _{opr}	0 to +70	C	
Storage temperature	T _{stg}	-55 to +125	C	

Notes : 1. Respect to V_{SS}

Recommended DC Operating Conditions (T_a = 0 to + 70C)

Parameter	Symbol	Min	Max	Unit	Note
Supply voltage	V _{CC} , V _{CCQ}	3.0	3.6	V	1
	V _{SS} , V _{SSQ}	0	0	V	
Input high voltage	V _{IH}	2.0	V _{CC} + 0.3	V	1, 2
Input low voltage	V _{IL}	-0.3	0.8	V	1, 3

Notes : 1. All voltage referred to V_{SS}.

2. V_{IH} (max) = 5.6V for pulse width ≤ 3ns

3. V_{IL} (min) = -2.0V for pulse width ≤ 3ns

DC Characteristics (Ta = 0 to 70C, VCC, VCCQ = 3.3V +/- 0.3V, VSS, VSSQ= 0 V)

Parameter		Symbol	- 8		- 7K		- 7J		- 10K		Unit	Test conditions	Notes
			Max		Max		Max		Max				
Operating current		ICC1	600						550		mA	Burst length= 1 t _{RC} = min	1, 2, 3
Standby current in power down		ICC2P	16								mA	CKE = V _{IL} , t _{CK} = 12 ns	5
Standby current in power down (input signal stable)		ICC2PS	8								mA	CKE=V _{IL} , t _{CK} = Infinity	6
			3.2										6,8
Standby current in non power down (CAS Latency=2)		ICC2N	120								mA	CKE,CS = V _{IH} , t _{CK} = 12ns	4
Standby current in non power down (input signal stable)		ICC2NS	100								mA	CKE,CS = V _{IH} , t _{CK} = Infinity	4
Active standby current in power down		ICC3P	40								mA	CKE = V _{IL} , t _{CK} = 12 ns, DQ = High-Z	1,2,5
Active standby current in power down (input signal stable)		ICC3PS	40								mA	CKE = V _{IL} , t _{CK} = Infinity	2,6
Active standby current in non power down		ICC3N	240								mA	CKE,CS = V _{IH} , t _{CK} = 12 ns, DQ = High-Z	1,2,4
Active standby current in non power down (input signal stable)		ICC3NS	240								mA	CKE,CS = V _{IH} , t _{CK} = Infinity	2,9
Burst operating current	(CL= 2)	ICC4	650		650		550		550	mA	t _{CK} = min BL = 4	1,2,3	
	(CL= 3)	ICC4	700		650		650		650	mA			
Refresh current		ICC5	1000		950		950		900	mA	t _{RC} = min	3	
Self refresh current		ICC6	16								mA	V _{IH} >=V _{CC} - 0.2 V _{IL} <=0.2V	7
			5										7,8

Parameter	Symbol	-8, -7K, -7J, -10K		Unit	Test conditions	Notes
		Min	Max			
Input leakage current	I _{LI}	-1	1	uA	0 ≤ V _{in} ≤ V _{CC}	
Output leakage current	I _{LO}	-1.5	1.5	uA	0 ≤ V _{out} ≤ V _{CC} DQ = disable	
Output high voltage	V _{OH}	2.4	-	V	I _{OH} = -2 mA	
Output low voltage	V _{OL}	-	0.4	V	I _{OL} = 2 mA	

Notes : 1. I_{CC} depends on output load condition when the device is selected. I_{CC} (max) is specified at the output open condition.

2. One bank operation.
3. Addresses are changed once per one cycle.
4. Addresses are changed once per two cycles.
5. After power down mode, CLK operating current.
6. After power down mode, no CLK operating current.
7. After self refresh mode set, self refresh current.
8. L-Version.
9. Input signals are V_{IH} or V_{IL} fixed.

Capacitance (T_a = 25°C, V_{CC}, V_{CCQ} = 3.3V +/- 0.3V)

Symbol	Parameter	Min	Max	Unit	Notes
C _{I1}	Input capacitance (A0 ~ A11, BA0,1)	-	55	pF	1, 3
C _{I2}	Input capacitance ($\overline{\text{RAS}}$, $\overline{\text{CAS}}$, $\overline{\text{WE}}$)	-	55	pF	1, 3
C _{I3}	Input capacitance (CK0, CK1)	-	40	pF	1, 3
C _{I4}	Input capacitance ($\overline{\text{S0}}$, $\overline{\text{S1}}$, CKE)	-	35	pF	1, 3
C _{I5}	Input capacitance (DQMB0 ~ DQMB7)	-	25	pF	1, 3
C _{I/O}	Input / output capacitance (DQ0 ~ DQ63)	-	25	pF	1, 2, 3

- Note :
1. Capacitance measured with Boonton Meter or effective capacitance measuring method.
 2. DQMB = V_{IH} to disable Dout.
 3. This parameter is sampled and not 100% tested.

AC Characteristics ($T_a = 0 \text{ to } 70^\circ\text{C}$, $V_{CC}, V_{CCQ} = 3.3 \text{ V} \pm 0.3 \text{ V}$, $V_{SS}, V_{SSQ} = 0 \text{ V}$)

Parameter		Symbol	- 8		- 7K		- 7J		- 10K		Unit	Notes
			Min	Max	Min	Max	Min	Max	Min	Max		
System clock cycle time	(CL=2)	t_{CK}	12	-	10	-	15	-	15	-	ns	1
	(CL=3)	t_{CK}	8	-	10	-	10	-	10	-		
CLK high pulse width		t_{CKH}	3	-	3	-	3	-	3	-	ns	1
CLK low pulse width		t_{CKL}	3	-	3	-	3	-	3	-	ns	1
Access time from CLK	(CL=2)	t_{AC}	-	6	-	6	-	8	-	9	ns	1, 2
	(CL=3)	t_{AC}	-	6	-	6	-	6	-	8		
Data-out hold time		t_{OH}	3	-	3	-	3	-	3	-	ns	1, 2
CLK to Data-out low impedance		t_{LZ}	2	-	2	-	2	-	2	-	ns	1, 2, 3
CLK to Data-out high impedance (CL = 2,3)		t_{HZ}	-	6	-	6	-	6	-	7	ns	1, 4
Data-in setup time		t_{DS}	2	-	2	-	2	-	2	-	ns	1
Data-in hold time		t_{DH}	1	-	1	-	1	-	1	-	ns	1
Address setup time		t_{AS}	2	-	2	-	2	-	2	-	ns	1
Address hold time		t_{AH}	1	-	1	-	1	-	1	-	ns	1
CKE setup time		t_{CES}	2	-	2	-	2	-	2	-	ns	1, 5
CKE setup time for power down exit		t_{CESP}	2	-	2	-	2	-	2	-	ns	1
CKE hold time		t_{CEH}	1	-	1	-	1	-	1	-	ns	1
Command ($\overline{CS}$, $\overline{RAS}$, $\overline{CAS}$, $\overline{WE}$, DQM) setup time		t_{CS}	2	-	2	-	2	-	2	-	ns	1
Command ($\overline{CS}$, $\overline{RAS}$, $\overline{CAS}$, $\overline{WE}$, DQM) hold time		t_{CH}	1	-	1	-	1	-	1	-	ns	1
Ref/Active to Ref/Active command period		t_{RC}	68	-	70	-	70	-	90	-	ns	1
Active to Precharge command period		t_{RAS}	48	120000	50	120000	50	120000	60	120000	ns	1
Active command to column command (same bank)		t_{RCD}	20	-	20	-	20	-	30	-	ns	1
Precharge to active command period		t_{RP}	20	-	20	-	20	-	30	-	ns	1

AC Characteristics (Ta = 0 to 70C, VCC, VCCQ = 3.3 V +/- 0.3 V, VSS, VSSQ = 0 V) (Continued)

Parameter	Symbol	- 8		- 7K		- 7J		- 10K		Unit	Notes
		Min	Max	Min	Max	Min	Max	Min	Max		
Write recovery or data-in to precharge lead time	t _{RWL}	8	-	10	-	10	-	15	-	ns	1
Active (a) to Active (b) command period	t _{RRD}	16	-	20	-	20	-	20	-	ns	1
Refresh period	t _{REF}	-	64	-	64	-	64	-	64	ms	

Notes : 1. AC measurement assumes t_r = 1ns. Reference level for timing of input signals is 1.40V.

If t_r is longer than 1ns, transition time compensation should be considered.

2. Access time is measured at 1.40V. Load condition is C_L = 50pF without termination.

3. t_{LZ} (min) defines the time at which the outputs achieves the low impedance state.

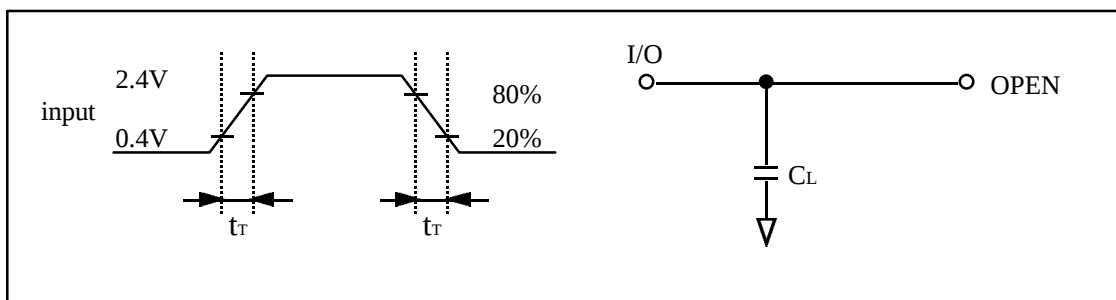
4. t_{HZ} (max) defines the time at which the outputs achieves the high impedance state.

5. t_{CES} define CKE setup time to CKE rising edge except Power down exit command.

Test Condition

Input and output-timing reference levels: 1.4V

Input waveform and output load: See following figures



Relationship Between Frequency and Minimum Latency

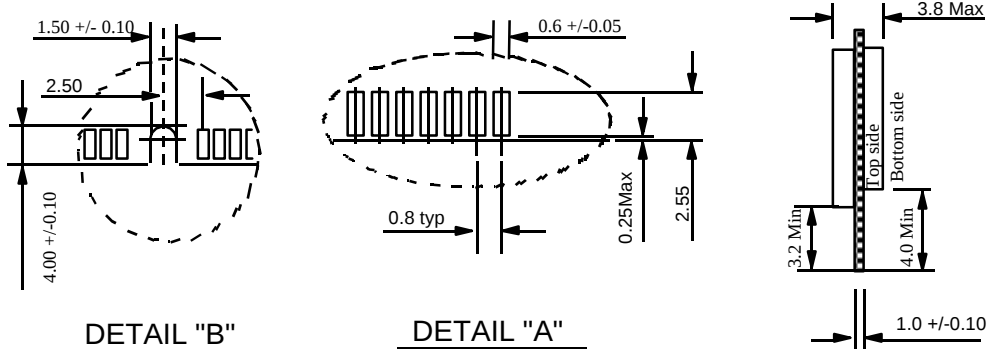
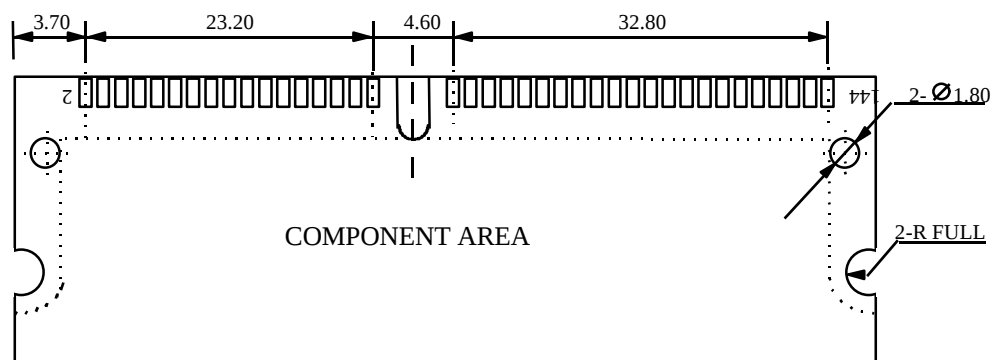
Parameter		-8		-7K		-7J		-10K		Notes
frequency(MHz)	Symbol	125	83	100	100	100	66	100	66	
t _{CK} (ns)		8	12	10	10	10	15	10	15	
Active command to column command (same bank)	I _{RCD}	3	2	2	2	2	2	3	2	1
Active command to active command (same bank)	I _{RC}	9	6	7	7	7	6	9	6	= [I _{RAS} + I _{RP}], 1
Active command to Precharge command (same bank)	I _{RAS}	6	4	5	5	5	4	6	4	1
Precharge command to active command (same bank)	I _{RP}	3	2	2	2	2	2	3	2	1
Write recovery or last data-in to Precharge command (same bank)	I _{RWL}	1	1	1	1	1	1	1	1	1
Active command to active command (different bank)	I _{RRD}	2	2	2	2	2	2	2	2	1
Self refresh exit time	I _{SREX}	1	2	1	1	1	2	2	2	
Last data in to active command (Auto Precharge, same bank)	I _{APW}	4	3	3	3	3	3	5	3	= [I _{RWL} + I _{RP}], 1
Self refresh exit to command input	I _{SEC}	9	6	7	7	7	6	9	6	= [I _{RC}]
Precharge command to high impedance	(CL=2) I _{HZP}	-	2	2	2	-	2	-	2	
	(CL=3) I _{HZP}	3	3	3	3	3	3	3	3	
Last data out to active command (auto Precharge) (same bank)	I _{APR}	1	1	1	1	1	1	1	1	
Last data out to Precharge (early Precharge)	(CL=2) I _{EP}	-	-1	-1	-1	-	-1	-	-1	
	(CL=3) I _{EP}	-2	-2	-2	-2	-2	-2	-2	-2	
Column command to column command	I _{CCD}	1	1	1	1	1	1	1	1	
Write command to data in latency	I _{WCD}	0	0	0	0	0	0	0	0	
DQM to data in	I _{DID}	0	0	0	0	0	0	0	0	
DQM to data out	I _{DOD}	2	2	2	2	2	2	2	2	
CKE to CLK disable	I _{CLE}	1	1	1	1	1	1	1	1	
Register set to active command	I _{RSA}	1	1	1	1	1	1	1	1	
$\overline{\text{CS}}$ to command disable	I _{CDD}	0	0	0	0	0	0	0	0	
Power down exit to command input	I _{PEC}	1	1	1	1	1	1	1	1	

Relationship Between Frequency and Minimum Latency

Parameter		Symbol	- 8		- 7K		- 7J		- 10K		Notes
frequency(MHz)			125	83	100	100	100	66	100	66	
t _{CK} (ns)			8	12	10	10	10	15	10	15	
Burst stop to output valid data hold	(CL=2)	I _{BSR}	-	1	1	1	-	1	-	1	
	(CL=3)	I _{BSR}	2	2	2	2	2	2	2	2	
Burst stop to output high impedance	(CL=2)	I _{BSH}	-	2	2	2	-	2	-	2	
	(CL=3)	I _{BSH}	3	3	3	3	3	3	3	3	
Burst stop to write data ignore		I _{BSW}	0	0	0	0	0	0	0	0	

Notes : 1. I_{RCD} to I_{RRD} are recommended value.

Unit: mm



NOTE : 1. Tolerances on all dimensions +/-0.15 unless otherwise specified.
2. Thickness(* Mark) includes Plating and / or Metallization.

SDRAM Memory Module EEPROM Data Information

GMM26417227ANTG-7J

00.05.09

Byte	Function described	Function support	HEX Code	DEC Code	BIN Code	Note
0	Define # bytes written into serial memory at module mfg	128 Bytes	80	128	10000000	
1	Total # bytes of SPD memory device	256 Bytes	08	008	00001000	
2	Fundamental memory type (FPM, EDO, SDRAM...) from appendix A	SDRAM	04	004	00000100	
3	# Row addresses on this assembly	12	0C	012	00001100	
4	# Column addresses on this assembly	9	09	009	00001001	
5	# Module banks on this assembly	2	02	002	00000010	
6	Data width of this assembly...	64 bit	40	064	01000000	
7	...Data width continuation	N/A	00	000	00000000	
8	Voltage interface standard of this assembly	LVTTL	01	001	00000001	
9	SDRAM cycletime	10.0 ns	A0	160	10100000	
10	SDRAM access from clock	6.0 ns	60	096	01100000	
11	DIMM configuration type (Non-parity, Parity, ECC)	None	00	000	00000000	
12	Refresh rate/type	Normal(15.625us)	80	128	10000000	
13	DRAM/SDRAM width, primary DRAM/SDRAM	x16	10	016	00010000	
14	Error checking SDRAM data width	N/A	00	000	00000000	
15	Minimum clock delay, back to back random column address(tCCD)	1 ns	01	001	00000001	
16	Burst lengths supported	Full Page Supported	8F	143	10001111	
17	# Banks on each SDRAM device	4 banks	04	004	00000100	
18	CAS # latency	2&3	06	006	00000110	
19	CS # latency	0	01	001	00000001	
20	Write latency	0	01	001	00000001	
21	SDRAM module attributes	Unbuffer	00	000	00000000	
22	SDRAM device attributes : General	Support All(VCC:10%)	0F	015	00001111	
23	Minimum clock cycle time at CL X-1	15.0 ns	F0	240	11110000	
24	Maximum data access time from clock at CL X-1	8.0 ns	80	128	10000000	
25	Minimum clock cycle time at CL X-2	N/A	00	000	00000000	
26	Maximum data access time from clock at CL X-2	N/A	00	000	00000000	
27	Minimum row precharge time(tRP)	20 ns	14	020	00010100	
28	Minimum row active to row active delay(tRRD)	20 ns	14	020	00010100	
29	Minimum RAS to CAS delay(tRCD)	20 ns	14	020	00010100	
30	Minimum RAS pulse width(tRAS)	50 ns	32	050	00110010	
31	Module bank density	64 MBytes	10	016	00010000	
32	Command and address signal input setup time(tAS)	2.0 ns	20	032	00100000	
33	Command and address signal input hold time(tAH)	1.0 ns	10	016	00010000	
34	Data signal input setup time(tDS)	2.0 ns	20	032	00100000	
35	Data signal input hold time(tDH)	1.0 ns	10	016	00010000	
36-61	Superset information (may be used in future)	TBD	00	000	00000000	
62	SPD revision	Rev 1.2	12	018	00010010	
63	Checksum for bytes 0-62		7F	127	11111111	
64	Manufacturers JEDEC ID code per JEP-106F	HME	E0	224	11100000	1st Group
65-71	... Continuation Manufacturers JEDEC ID Code		00	000	00000000	
72	Manufacturing location	Korea	52	082	01010010	82d(free)
73	Manufacturer's part number	GMM26417227ANTG-7J	47	071	01000111	G
74	=== Allowed characters include 0-9, A-Z and 'space' ===		4D	077	01001101	M
75			4D	077	01001101	M
76			32	050	00110010	2
77			36	054	00110110	6
78			34	052	00110100	4
79			31	049	00110001	1
80			37	055	00110111	7
81			32	050	00110010	2
82			32	050	00110010	2
83			37	055	00110111	7
84			41	065	01000001	A
85			4E	078	01001110	N
86			54	084	01010100	T
87			47	071	01000111	G
88			2D	045	00101101	-
89			37	055	00110111	7
90			4A	074	01001010	J
91	Revision Code	Rev 0	00	000	00000000	
92	Revision Code		00	000	00000000	
93	Date Code	WW	14	020	00010100	20 ww
94		YY	00	000	00000000	0 year
95-98	Assembly serial number	Binary incremental	00	000	00000000	98byte start
99-125	Manufacturer specific data	N/A	00	000	00000000	
126	Intel specification for frequency	100 MHz	64	100	01100100	
127	Intel specification details for 100Mhz Support	CK0_1_CL3	CD	205	11001101	
128-135	System integrator's ID		00	000	00000000	
136-150	System integrator's P/N		00	000	00000000	
151-152	System integrator's D/C		00	000	00000000	
153-165	System integrator's S/N		00	000	00000000	
166	Checksum for bytes 128-165		00	000	00000000	
167-189	Top level system serial no.		00	000	00000000	
190-221	Open		00	000	00000000	
222	Checksum for bytes 167-221		00	000	00000000	
223-253	Open		00	000	00000000	
254	Checksum for Bytes 223-253		00	000	00000000	
255	Checksum for bytes 0-128		00	000	00000000	

SDRAM Memory Module EEPROM Data Information

GMM26417227ANTG-7K

00.05.09

Byte	Function described	Function support	HEX Code	DEC Code	BIN Code	Note
0	Define # bytes written into serial memory at module mfg	128 Bytes	80	128	10000000	
1	Total # bytes of SPD memory device	256 Bytes	08	008	00001000	
2	Fundamental memory type (FPM, EDO, SDRAM...) from appendix A	SDRAM	04	004	00000100	
3	# Row addresses on this assembly	12	0C	012	00001100	
4	# Column addresses on this assembly	9	09	009	00001001	
5	# Module banks on this assembly	2	02	002	00000010	
6	Data width of this assembly...	64 bit	40	064	01000000	
7	...Data width continuation	N/A	00	000	00000000	
8	Voltage interface standard of this assembly	LVTTL	01	001	00000001	
9	SDRAM cycletime	10.0 ns	A0	160	10100000	
10	SDRAM access from clock	6.0 ns	60	096	01100000	
11	DIMM configuration type (Non-parity, Parity, ECC)	None	00	000	00000000	
12	Refresh rate/type	Normal(15.625us)	80	128	00000000	
13	DRAM/SDRAM width, primary DRAM/SDRAM	x16	10	016	00010000	
14	Error checking SDRAM data width	N/A	00	000	00000000	
15	Minimum clock delay, back to back random column address(tCCD)	1 ns	01	001	00000001	
16	Burst lengths supported	Full Page Supported	8F	143	10001111	
17	# Banks on each SDRAM device	4 banks	04	004	00000100	
18	CAS # latency	2&3	06	006	00000110	
19	CS # latency	0	01	001	00000001	
20	Write latency	0	01	001	00000001	
21	SDRAM module attributes	Unbuffer	00	000	00000000	
22	SDRAM device attributes : General	Support All(VCC:10%)	0F	015	00001111	
23	Minimum clock cycle time at CL X-1	10.0 ns	A0	160	10100000	
24	Maximum data access time from clock at CL X-1	6.0 ns	60	096	01100000	
25	Minimum clock cycle time at CL X-2	N/A	00	000	00000000	
26	Maximum data access time from clock at CL X-2	N/A	00	000	00000000	
27	Minimum row precharge time(tRP)	20 ns	14	020	00010100	
28	Minimum row active to row active delay(tRRD)	20 ns	14	020	00010100	
29	Minimum RAS to CAS delay(tRCD)	20 ns	14	020	00010100	
30	Minimum RAS pulse width(tRAS)	50 ns	32	050	00110010	
31	Module bank density	64 MBytes	10	016	00010000	
32	Command and address signal input setup time(tAS)	2.0 ns	20	032	00100000	
33	Command and address signal input hold time(tAH)	1.0 ns	10	016	00010000	
34	Data signal input setup time(tDS)	2.0 ns	20	032	00100000	
35	Data signal input hold time(tDH)	1.0 ns	10	016	00010000	
36-61	Superset information (may be used in future)	TBD	00	000	00000000	
62	SPD revision	Rev 1.2	12	018	00010010	
63	Checksum for bytes 0-62		0F	015	1111	
64	Manufacturers JEDEC ID code per JEP-106F	HME	E0	224	11100000	1st Group
65-71	... Continuation Manufacturers JEDEC ID Code		00	000	00000000	
72	Manufacturing location	Korea	52	082	01010010	82d(free)
73	Manufacturer's part number	GMM26417227ANTG-7K	47	071	01000111	G
74	=== Allowed characters include 0-9, A-Z and 'space' ===		4D	077	01001101	M
75			4D	077	01001101	M
76			32	050	00110010	2
77			36	054	00110110	6
78			34	052	00110100	4
79			31	049	00110001	1
80			37	055	00110111	7
81			32	050	00110010	2
82			32	050	00110010	2
83			37	055	00110111	7
84			41	065	01000001	A
85			4E	078	01001110	N
86			54	084	01010100	T
87			47	071	01000111	G
88			2D	045	00101101	-
89			37	055	00110111	7
90			4B	075	01001011	K
91	Revision Code	Rev 0	00	000	00000000	
92	Revision Code		00	000	00000000	
93	Date Code	WW	14	020	00010100	20 ww
94		YY	00	000	00000000	0 year
95-98	Assembly serial number	Binary incremental	00	000	00000000	98byte start
99-125	Manufacturer specific data	N/A	00	000	00000000	
126	Intel specification for frequency	100 MHz	64	100	01100100	
127	Intel specification details for 100Mhz Support	CK0_1_CL2	CF	207	11001111	
128-135	System integrator's ID		00	000	00000000	
136-150	System integrator's P/N		00	000	00000000	
151-152	System integrator's D/C		00	000	00000000	
153-165	System integrator's S/N		00	000	00000000	
166	Checksum for bytes 128-165		00	000	00000000	
167-189	Top level system serial no.		00	000	00000000	
190-221	Open		00	000	00000000	
222	Checksum for bytes 167-221		00	000	00000000	
223-253	Open		00	000	00000000	
254	Checksum for Bytes 223-253		00	000	00000000	
255	Checksum for bytes 0-128		00	000	00000000	